

Notice of References Cited	Application/Control No. 10/775,177	Applicant(s)/Patent Under Reexamination OHTA ET AL.	
	Examiner John Wahnkyo Lee	Art Unit 2624.	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,553,206 A	11-1985	Smutek et al.	707/101
*	B	US-5,515,179 A	05-1996	Yamakawa et al.	358/447
*	C	US-5,933,823 A	08-1999	Cullen et al.	707/6
*	D	US-2002/0044686 A1	04-2002	Yamazaki, Tsutomu	382/167
*	E	US-6,879,724 B2	04-2005	Yamaguchi et al.	382/232
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.